

22.5°Angle Mini DIMM, 200 / 244 Ckt 0.60mm pitch SMT

1.0 SCOPE

This Product Specification covers the performance requirements of the 0.60 mm centerline edge card socket for board to board interconnect of 1.00 mm thick memory modules.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER (S)

<u>Series Number</u>	Product Descriptions
87783	200/244 Ckt 22.5 Deg Angle Mini DIMM

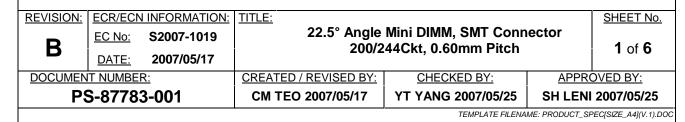
2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate Sales Drawings for information on dimensions, materials, plating and markings, recommended module outlines and footprint Specifications.

2.3 SAFETY AGENCY APPROVALS

UL File	:	E29179
CSA File	:	1699020 (LR 19980)







3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

The following documents are part of this specification between the requirements of this specified herewith. In the event of conflict between the requirements of this specification and the product drawings, the product drawings shall take precedence. In the event of conflict between the requirements of this specification and reference documents, this specification shall take precedence.

4.0 RATINGS

4.1 VOLTAGE

30 VRMS at 60 Hz

4.2 CURRENT

1.0 Amps at 30°C Temperature Rise

4.3 TEMPERATURE

Operating Temperature: -55°C to +85°C

5.0 PERFORMANCE

5.1 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Contact Resistance (Low Level)	Mate connectors: apply a maximum voltage of 20 mV and a current of 100 mA. EIA-364-23	40 mΩ maximum at initial 10 mΩ maximum change from initial
2	Temperature Rise at rated current	Temperature of mater connector at rated current for 96 hours (6 consecutive ckts link in series)	1.0 Amps per contact at a maximum of 30°C temperature rise
3	Insulation Resistance	Unmate & unmount connectors: apply a voltage of 500 VDC between adjacent terminals and between terminals to ground. EIA-364-21	1000 Mega Ω minimum
4	Dielectric Withstanding Voltage	Apply 500 VAC for 1 minute between adjacent terminals of an unmated connector. EIA-364-20	No breakdown or flashover

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PS-87783-001			CM TEO 2007/05/17	YT YANG 2007/05/25	SH LEN	2007/05/25
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5.2 MECHANICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION		REQUIREM	ENT			
5	Vibration	Amplitude : 1.50mm peak to pe Sweep : 10-55-10 Hz in one mi Duration : 2 hrs each on XYZ a Module weight : 15g for 244Ckt 200Ckt. EIA 364-28	reep : 10-55-10 Hz in one min. ration : 2 hrs each on XYZ axis dule weight : 15g for 244Ckt and 13g for 1000000000000000000000000000000000000					
6	Shock (Mechanical)	half-sine waveform for 11 millis shocks in each perpendicular a shocks total).	dule weight : 15g for 244Ckt and 13g for 1.0 micro sec.					
7	Durability	Mate and unmated connectors u cycles at a maximum rate of 10 minute.		No change in LLCR than 10 m Ω from in				
8	Module Insertion Force (w/ Latches)	Insert a 1.00 mm thick Module(C chamfer) at a rate of 25 ± 6 mm per minute. See Sales drawing Module details.	(1 ± ¼ inch)	n Total insertion force not to exceed : 195.0 N (43.73lbs) for 200 ck 238.0 N (53.37lbs) for 244 ck				
9	Module Rip Out Force	Apply a pulling force on module of $25 \pm 6 \text{ mm/}$ min. ($1 \pm \frac{1}{4}$ inch) with recommen module as per sales drawing, ins connector with latches closed.	te 35.0 N (7.85lbs) min. retention force of the module in connector with no damage					
10	Latch Actuation Force	Apply an actuation force on eac rate of 25 ± 6 mm/ min ($1 \pm \frac{1}{4}$ i recommended test module as p drawing, inserted into connecto	nch) with per sales	The force to fully actuate the latch open shall be 35 N (7.85lbs) max. per latch.				
11	Latch Overstress Force	Apply an actuation force on eac rate of $25 \pm 6 \text{ mm} / \text{min} (1 \pm \frac{1}{4} \text{ fully open position.}$		35 N (7.85lbs) min force with no damage.				
12	Terminal Retention Force	Axial pullout force on the termin housing at a rate of 25 ± 6 mm per minute.		3 N minimum				

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5.3 ENVIRONMENTAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION		REQ	UIREMEN	IT	
13	Shock (Thermal)	-55 +0/-3 30 +25 ±10 5 MA +85 +3/-0 30 30	<u>n (Minutes)</u> AXIMUM AXIMUM	No change than 10 m <u>໌</u>			
14	Thermal Aging	Mate connectors and expose 105 ± 2°C. Per EIA-364-17	e to 48 hours at	μ rs at No change in LLCR greater than 10 m Ω from initial.			
15	Cyclic Temperature & Humidity	Mate connectors and expose 25°C to 65°C at 90-98% RH. Per EIA-364-31, Method III.		No change than 10 ms			
16	Solderability	Solder time: 5±0.5 sec Solder temperature: 260±5°C Subject to steam aging for 8		Solder cov 95% minim	•		
17	Porosity	Nitric Acid Test, 10 contacts selected at random. Per EIA 364-53	per contact type	Maximum 30uin-1 po contacts		pores :	
18	Solvent Resistance	42 parts DI water by volume, 1 part of propylene glycol monomethyl ether(Glycol ether PM, 1 methoxy-2-propanol). 1 part by volume of monoethanolamine. Per MIL-STD-202F Method 215J					
19	Resistance to Soldering Heat Test	Unmated, exposed to reflow defined in Section 8.1.	profile as	No Damag	e or bliste	ring.	
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6.0 TEST SEQUENCE

Test Description						Test	t Grou	р				
Sequence	1	2	3	4	5	6	7	8	9	10	11	12
Contact Resistance	1 3 5 7	1 3	1 3 5									
Temperature Rise											1	
Insulation Resistance				1 5								
Dielectric Withstand Voltage				2 6								
Vibration	6											
Mechanical Shock	4											
Durability	2											
Module Insertion Force					1							
Module Ripout Force					2							
Latch Actuation Force												1
Latch Overstress Force												2
Thermal Shock			2	3								
Thermal Aging		2										
Cyclic Temp & Humidity			4	4								
Plating thickness						1						
Solderability								1				
Porosity									1			1
Solvent Resistance							1					
Terminal Retention Force										1 3		
Resistance to Soldering Heat										2		
Sample Size per Test Group	5	5	5	5	5	5	5	5	5	10	5	5

7.0 PACKAGING

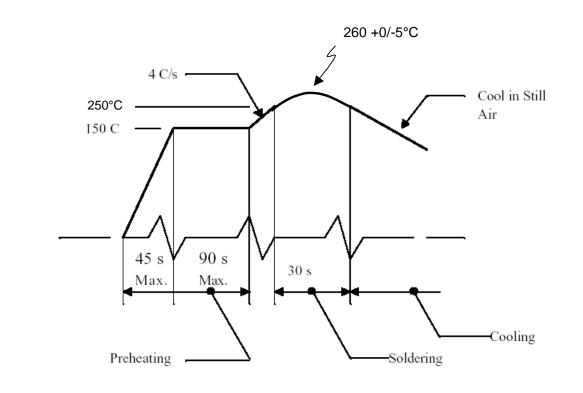
Parts shall be packed in trays and protected against damage during handling, transportation and storage.

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8.0 OTHER INFORMATIONS

8.1 Reflow Profile.



Notes :

- 1. Reflow solder Preheat at 3°C/s to 150°C.
- 2. Reflow at 250°C for 30s per figure.
- 3. Peak temperature to be at 260 +0/-5°C
- 4. Component must withstand (2) reflow solder cycles with a cool down between.

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